

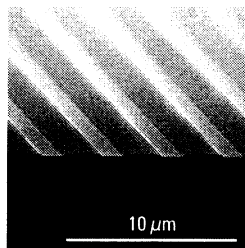
**ULTRASHARP**  
CANTILEVERS & GRATINGS

**TGZ02**

[ test structure ]



**TGZ02**



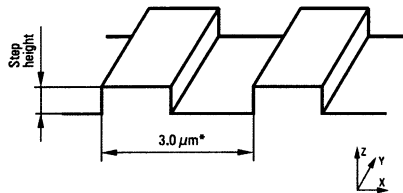
SEM image of one of the silicon grating of TGZ Series.

**Grating Characteristics:**

Active area: ..... **3x3 mm**

Step height: ..... **102 nm**

Accuracy: ..... **1,5 nm**



\* given for information only

Silicon calibration gratings of the TGZ series comprise a one-dimensional array of rectangular steps with a calibrated height value. The gratings are intended for Z-axis calibration of SPM scanners.